Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10700764	LAUCH, RICHARD	
Examiner	Art Unit	
Kruer, Stefan	3654	

SEARCHED						
Class	Subclass	Date	Examiner			
187	298, 299, 377	02/05/2007	SHK			
220	3.3, 210,212.5,262					

SEARCH NOTES		
Search Notes	Date	Examine
 INTERFERENCE SEA	RCH	